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S4	832	(330/129).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S5	884	(455/126).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:28
S6	494	(455/232.1).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:31
S9	387	(330/278).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 12:46
S16	576	(330/297).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2005/07/01 13:03
S21	12	amplifier and detect\$3 and ((current near1 voltage) near1 conver\$5) and bias\$3 and capacit\$5 and (resistor or resistive or resistance)	EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/11/18 11:45
S24	150	amplifier and detect\$3 and ((current near1 voltage) near1 conver\$5) and bias\$3 and "330"/\$. ccls. and @ad<="20030422"	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/18 11:50
S31	554	amplifier and (detect\$3 same ((current near1 voltage) near1 conver\$5)) and bias\$3 and feedback	US-PGPUB; USPAT; USOCR	OR	ON	2005/11/18 11:51



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IEEE JNL IEEE Journal or Magazine

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 Microwave Theory and Techniques, IEEE Transactions on
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 AbstractPlus References Full Text: PDF(240 KB) IEEE JNL</p> |
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 Kuroda, T.; Fukunaga, T.; Matsuo, K.; Kasai, K.; Hirata, A.; Fujii, S.; Kimura, M.; Suzuki, H.;
 Solid-State Circuits, IEEE Journal of
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 Electrical and Electronics Engineers in Israel, 1995., Eighteenth Convention of
 7-8 March 1995 Page(s):
 Digital Object Identifier 10.1109/EEIS.1995.513837
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 Gupta, D.; Kadin, A.M.;
 Applied Superconductivity, IEEE Transactions on
 Volume 9, Issue 2, Part 3, June 1999 Page(s):4487 - 4490
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 AbstractPlus References Full Text: PDF(460 KB) IEEE JNL</p> |
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 O'Connor, P.; Gramegna, G.; Rehak, P.; Corsi, F.; Marzocca, C.;
 Nuclear Science, IEEE Transactions on</p> |

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